

# Automated X-ray Inspection System Transmission - SFT™



## X2# High-Power (HP) setup

Flexible In-line X-ray system

The **MatriX X2#** is an automated inspection system designed for sophisticated high-speed inspection in SMT production. Transmission X-ray Technology with patented Slice-Filter-Technique™ (SFT) present a reliable solution for the inline inspection of double-sided PCB assemblies. The X2# movable detector axes allow high-speed off-axis image acquisition from different angles and directions with maximum image quality and resolution.

**MIPS\_Tune** is an off-line programming software package for test program generation with automatic CAD import and for graphical application parameter tuning. It features an automatic inspection list generation based on an advanced algorithm library for transmission and off-axis joint inspection.

Proprietary **Tree-Classification** technique with integrated automatic rule generation, graphical measurement & yield display for program optimization. The verification software module **MIPS\_Verify** with its closed-loop repair concept is capable of in-line or off-line verification using a graphical board layout display and X-ray image with defect marking. Support of multiple inspection modes with parallel viewing of transmission oblique view and optical images of the same defect for easy and reliable defect verification.

**MIPS\_SPC** – process control tools for real-time and history statistics.

### Features and Benefits

- High Speed AXI System for Inline and Offline setups
- Microfocus X-RAY tube (sealed tube / maintenance free) up to 130kV/40W
- 3-axes programmable motion system with servo drives (x-y sample table, z-axes x-ray tube)
- Digital CMOS flatpanel detector (14 bit digital output) or 16 bit high-dynamic setup (Amorphous Silicon Tech)
- Automatic grey-level and geometrical calibration
- In-line pass through board handling with automatic width adjust
- Barcode scanner (1D/2D) for serial number and product type selection
- Full product traceability via customized MES-Interface
- Optional: Tray conveyor handling system
- External programmable barcode scanner unit with x,y motion scanner head

### Inspection & Process Software

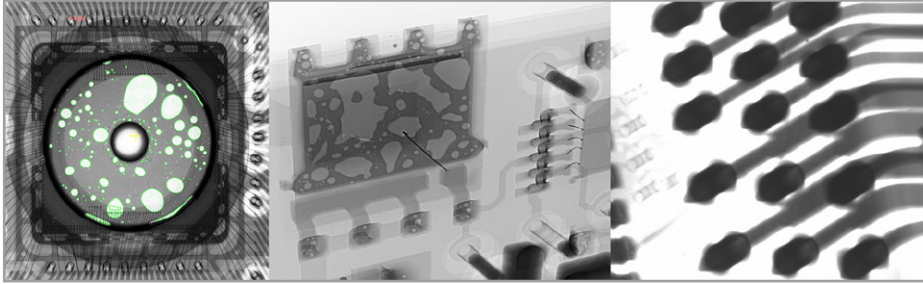
- PC-Station with multi-core processor setup
- Windows 7 or Windows 10 platform
- CAD Import for automatic inspection list generation
- Advanced Algorithm Inspection Library for solder joint and component inspection
- Slice-Filter-Technique™ (SFT) for double-sided board inspection
- Automatic-Tree Classification (ATC) for Auto-Rule-Generation
- Off-line programming for AXI program generation & simulation, tuning and defect reference catalogue
- MIPS\_Verify link with closed-loop repair
- MIPS\_SPC for real-time process control

## Applications

### POWER HYBRID (VOIDING) AND PTH (BARREL-FILL) INSPECTION

A unique advanced algorithm library is available for electronic applications, specifically for SMT/PTH components and power hybrids & motion:

- All standard SMD and THT/PTH components
- PTH/THT Barrel Fill Measurement
- Specific BGA and QFN algorithm
- Advanced cooling plates / heatsink
- Off-axis image analysis of e.g. BGA (HIP)
- Void inspection



## Specifications

### Facilities

#### Dimensions:

1670 mm (H) x 3100 mm (W) x 1760 mm (D)

#### Adjustable conveyor height (SMEMA):

890 – 980 mm

#### Weight: 3.000 kg

#### Safe Operating Temperature:

15° - 32 °C optimal 20° - 25° C

#### Power Consumption: max. 6 kW

**Line Voltage:** 400 VAC, 50/60 Hz 3 phase, 16 A  
208 VAC, 50/60 Hz 3 phase, 25 A

**Air:** 5-7 Bar, < 2 l/min, filtered (30µ), dry, oil free

### Part Handling / Motion

High-speed sample table

**Driving distance X,Y:** 510 mm x 410 mm

**X-Ray tube (Z):** 0 - 150 mm

**Detector Axes (U,V):** 220 mm x 200 mm

X-ray Source (sealed tube)

**Energy:** 150 kV/75 W

**Focal Spot Size:** 5-7 microns

**X-Ray Tube Orientation:** End window tube

### X-ray Imaging

**Video output:** Camera link interface

#### Detector Type A (14bit) (75µ):

CMOS Detector (1,5k x 1,5k)

**Active inspection area:** 115 x 115 mm

#### Detector Type B (16bit) (100/200µ):

ASI Detector (1k x 1k)

**Active inspection area:** 200 x 200 mm

#### High-Dynamic (16bit) setup

### Inspection features

**Angle shot capability:** 0 – 25 dgr

Standard FoV setup

**Transmission FoV:** (10 mm) to (40 mm)

**Object resolution (@min. FoV):** 4-5 µm

LFoV-setup:

**Transmission FoV:** (15 mm) to (50 mm)

**Object resolution (@min. FoV):** 7-8 µm

### Sample Inspection Parameter

Standard setup:

**Max. board size:** 20"x 16" (510 mm x 410 mm)

**Optional: XL-Version:** 600 x 410mm

**Max. inspection area:** 19"x 16" (480 mm x 410 mm)

Customized tray design upon request

Assembly Clearance

**Topside (incl. board thickness):** 80 mm

**Bottom side (excl. board thickness):** 45 mm

**Edge clearance for clamping:** 3 mm

**For more information, speak with your MatriX representative.**

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